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MOSFET – Power, Single, N-Channel, SO-8FL 30 V, 191 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

Applications

- Refer to Application Note AND8195/D
- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

MAXIMUM RATINGS (T_J = 25° C unless otherwise stated)

Para	meter		Symbol	Value	Unit
Drain-to-Source Volt	age		V _{DSS}	30	V
Gate-to-Source Volta	age		V _{GS}	±20	V
Continuous Drain Current R _{θJA}		$T_A = 25^{\circ}C$	Ι _D	28	А
(Note 1)		T _A = 85°C		20.5	
Power Dissipation $R_{\theta JA}$ (Note 1)		$T_A = 25^{\circ}C$ P_D	2.7	W	
Continuous Drain		$T_A = 25^{\circ}C$	ID	16	А
Current R _{θJA} (Note 2)	Steady	T _A = 85°C		30 ±20 28 20.5 2.7	
Power Dissipation $R_{\theta JA}$ (Note 2)	State	T _A = 25°C	PD		W
Continuous Drain		$T_{C} = 25^{\circ}C$	I _D	191	А
Current R _{θJC} (Note 1)		$T_{C} = 85^{\circ}C$		138	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	113.6	W
Pulsed Drain Current		= 25°C, = 10 μs	I _{DM}	288	А
Operating Junction an Temperature	nd Storage	•	T _J , T _{STG}		°C
Source Current (Body	/ Diode)		۱ _S	104	А
Drain to Source dV/d	t		dV/dt	6	V/ns
Single Pulse Drain-to Energy ($T_J = 25^{\circ}C$, V $I_L = 35 A_{pk}$, L = 1.0 m	Steady State State T _A t_p and Storage dy Diode) dt to-Source A $V_{DD} = 30 V$, nH, R _G = 23 or Soldering	V _{GS} = 10 V,	EAS	612.5	mJ
Lead Temperature for (1/8" from case for 10		Purposes	ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

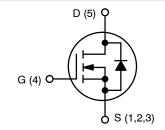
1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.



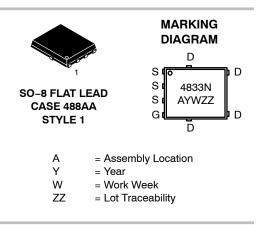
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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	2.0 m Ω @ 10 V	101.4
30 V	3.0 mΩ @ 4.5 V	191 A



N-CHANNEL MOSFET



ORDERING INFORMATION

	Device	Package	Shipping [†]
	NTMFS4833NT1G	SO-8FL (Pb-Free)	1500/Tape & Reel
	NTMFS4833NT3G	SO-8FL (Pb-Free)	5000/Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please

refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

2. Surface–mounted on FR4 board using the minimum recommended pad size. (Cu area = 50 mm² [1 oz])

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ ext{ heta}JC}$	1.1	
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	45.6	°C/W
Junction-to-Ambient - t < 10s (Note 3)	$R_{ hetaJA}$	17.1	-C/VV
Junction-to-Ambient - Steady State (Note 4)	$R_{ hetaJA}$	117.4	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size. (Cu area = 50 mm² [1 oz])

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 V, I_D$	= 250 μA	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				17		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$	T _J = 25 °C			1	
		V _{DS} = 24 V	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS}$	_S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)					-	-	
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D	= 250 μA	1.5		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				7.12		mV/°C
Drain-to-Source On Resistance		11.5 V	I _D = 30 A		1.3	2.0	
			I _D = 15 A		1.3]
		V _{GS} = 4.5 V	I _D = 30 A		2.3	3.0	mΩ
			I _D = 15 A		2.3		
Forward Transconductance	9 _{FS}	V _{DS} = 15 V, I	_D = 15 A		30		S
CHARGES, CAPACITANCES & GATE RESIS	STANCE				-	-	
Input Capacitance	C _{ISS}				5600		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MH	lz, V _{DS} = 12 V		1200		pF
Reverse Transfer Capacitance	C _{RSS}				650		1
Total Gate Charge	Q _{G(TOT)}				39	58	
Threshold Gate Charge	Q _{G(TH)}				6.0		
Gate_to_Source Charge	000	V_{GS} = 4.5 V, V_{DS} =	15 V; I _D = 30 A		16		nC

6	·G(11)	V_{GS} = 4.5 V, V_{DS} = 15 V; I_{D} = 30 A		
Gate-to-Source Charge	Q _{GS}	$v_{GS} = 4.5 v, v_{DS} = 15 v, I_D = 50 R$	16	
Gate-to-Drain Charge	Q _{GD}		17	
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 11.5 V, V_{DS} = 15 V; I_{D} = 30 A	88	

SWITCHING CHARACTERISTICS (Note 6)

Turn-On Delay Time	t _{d(ON)}		25	
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 15 A,	34	
Turn-Off Delay Time	t _{d(OFF)}	R _G = 3.0 Ω	35	ns
Fall Time	t _f		17	
Turn-On Delay Time	t _{d(ON)}		14	
Rise Time	t _r	V _{GS} = 11.5 V, V _{DS} = 15 V,	19	
Turn-Off Delay Time	t _{d(OFF)}	V_{GS} = 11.5 V, V_{DS} = 15 V, I _D = 15 A, R _G = 3.0 Ω	50	ns
Fall Time	t _f		10	

nC

5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

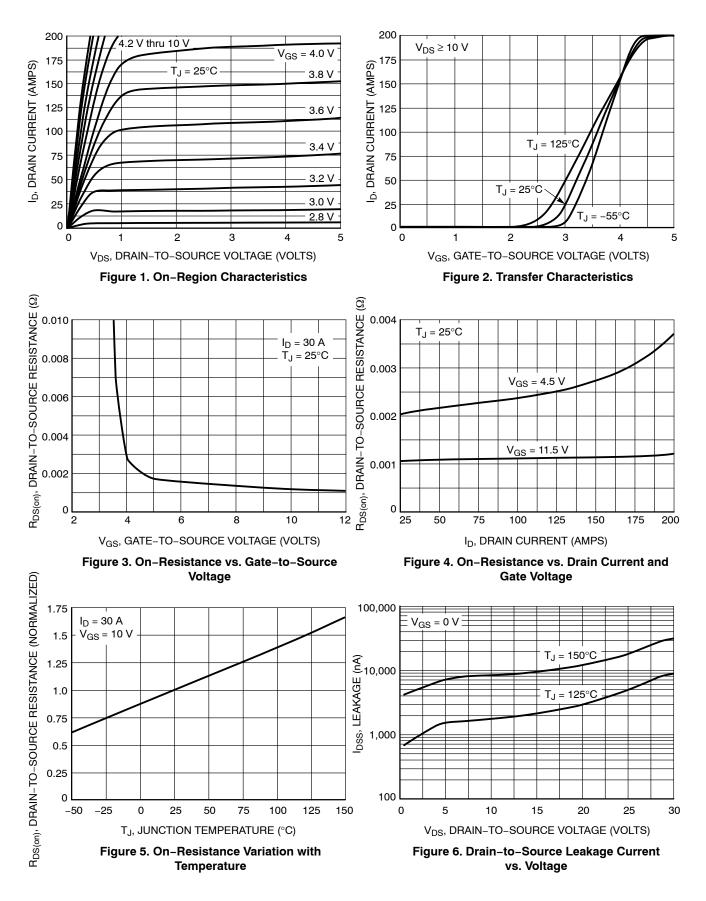
6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

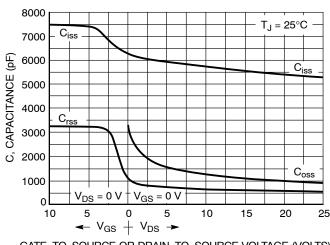
Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTE	ERISTICS						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V, I_{S} = 30 A T_{J} = 25^{\circ}C T_{J} = 125^{\circ}C$	-	0.8	1.0	V	
			T _J = 125°C	-	0.68	-	V
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/µs, I _S = 30 A		-	38	-	ns
Charge Time	t _a			-	19	-	
Discharge Time	t _b			-	19	-	
Reverse Recovery Charge	Q _{RR}			-	36	-	nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S			-	0.50	-	nH
Drain Inductance	L _D	T _A = 25°C		-	0.005	-	nH
Gate Inductance	L _G			-	1.84	-	nH
Gate Resistance	R _G			-	1.0	-	Ω

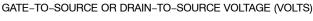
Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

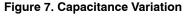
TYPICAL PERFORMANCE CURVES

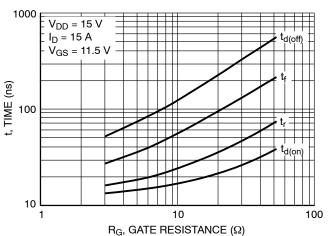


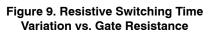
TYPICAL PERFORMANCE CURVES











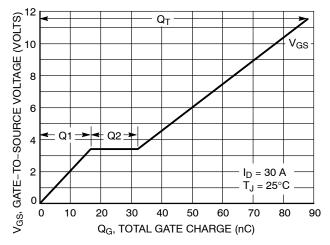


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

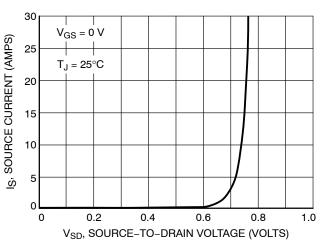
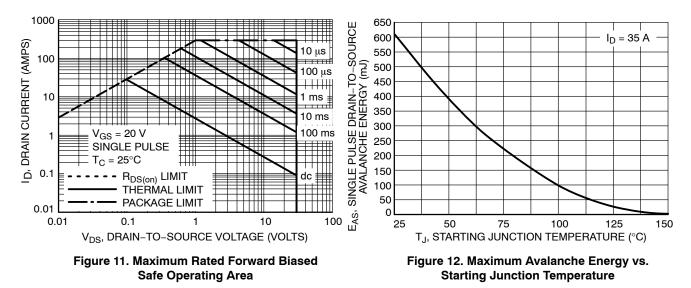


Figure 10. Diode Forward Voltage vs. Current



TYPICAL PERFORMANCE CURVES

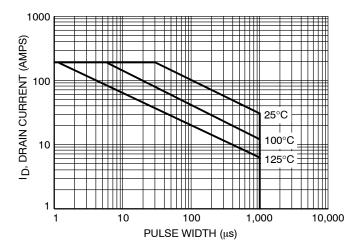


Figure 13. Avalanche Characteristics

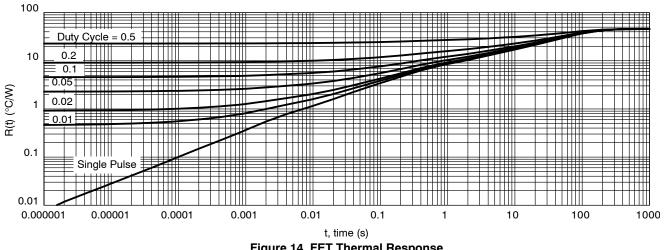
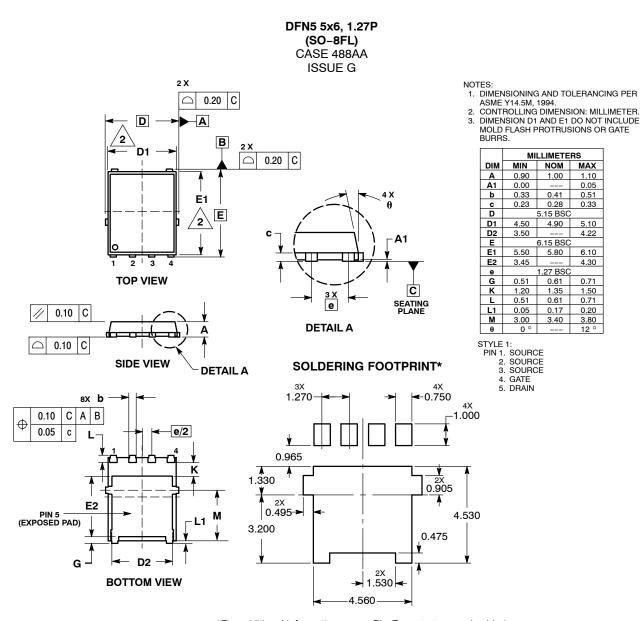


Figure 14. FET Thermal Response

PACKAGE DIMENSIONS



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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